Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | RHEE ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,031,512	02-2000	Kadota et al.	345/88
	В	US-5,754,261	05-1998	Lyu, Ki Hyun	349/44
	С	US-RE33,882	04-1992	Morozumi, Shinji	345/88
	D	US-6,787,275	09-2004	Kawase, Tomomi	430/7
	Е	US-5,587,819	12-1996	Sunohara et al.	349/106
	F	US-2002/0074549	06-2002	Park et al.	257/59
	G	US-6,798,471	09-2004	Yamada, Tsutomu	349/106
	Н	US-2002/0145695	10-2002	Kim et al.	349/141
	ı	US-6,785,068	08-2004	Takizawa et al.	359/885
	J	US-			
	К	US-			
•	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*	i	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0		-			
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	υ							
	٧	·						
	w							
	x							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.